

# Dual P-channel MOSFET

ELM14817AA-N

## General description

ELM14817AA-N uses advanced trench technology to provide excellent  $R_{ds(on)}$  and low gate charge. Internal ESD protection is included.

## Features

- $V_{ds} = -30V$
- $I_d = -8A$  ( $V_{gs} = -20V$ )
- $R_{ds(on)} < 18m\Omega$  ( $V_{gs} = -20V$ )
- $R_{ds(on)} < 21m\Omega$  ( $V_{gs} = -10V$ )
- ESD Rating : 1500V HBM

## Maximum absolute ratings

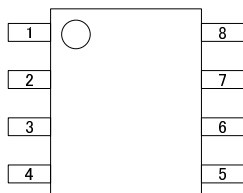
Parameter		Symbol	Limit	Unit	Note
Drain-source voltage		$V_{ds}$	-30	V	
Gate-source voltage		$V_{gs}$	$\pm 25$	V	
Continuous drain current	$T_a = 25^\circ C$	$I_d$	-8.0	A	1
	$T_a = 70^\circ C$		-6.9		
Pulsed drain current		$I_{dm}$	-40	A	2
Power dissipation	$T_a = 25^\circ C$	$P_d$	2.00	W	1
	$T_a = 70^\circ C$		1.44		
Junction and storage temperature range		$T_j, T_{stg}$	-55 to 150	$^\circ C$	

## Thermal characteristics

Parameter		Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	$t \leq 10s$	$R\theta_{ja}$	50.0	62.5	$^\circ C/W$	1
Maximum junction-to-ambient	Steady-state		73.0	110.0	$^\circ C/W$	
Maximum junction-to-lead	Steady-state	$R\theta_{jl}$	31.0	40.0	$^\circ C/W$	3

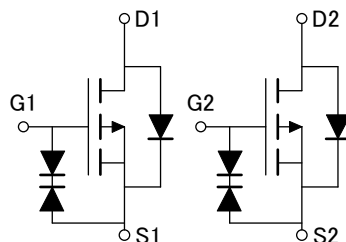
## Pin configuration

SOP-8 (TOP VIEW)



Pin No.	Pin name
1	SOURCE2
2	GATE2
3	SOURCE1
4	GATE1
5	DRAIN1
6	DRAIN1
7	DRAIN2
8	DRAIN2

## Circuit



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## Electrical characteristics

Ta=25°C

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
STATIC PARAMETERS						
Drain-source breakdown voltage	BV <sub>dss</sub>	I <sub>d</sub> =-250 μA, V <sub>gs</sub> =0V	-30			V
Zero gate voltage drain current	I <sub>dss</sub>	V <sub>ds</sub> =-24V			-1	μA
		V <sub>gs</sub> =0V, T <sub>j</sub> =55°C			-5	
Gate-body leakage current	I <sub>gss</sub>	V <sub>ds</sub> =0V, V <sub>gs</sub> =±25V			±1	μA
Gate threshold voltage	V <sub>gs(th)</sub>	V <sub>ds</sub> =V <sub>gs</sub> , I <sub>d</sub> =-250 μA	-1.0	-2.8	-3.0	V
On state drain current	I <sub>d(on)</sub>	V <sub>gs</sub> =-10V, V <sub>ds</sub> =-5V	-40			A
Static drain-source on-resistance	R <sub>ds(on)</sub>	V <sub>gs</sub> =-20V		14.1	18.0	mΩ
		I <sub>d</sub> =-8A, T <sub>j</sub> =125°C		20.0	25.0	
		V <sub>gs</sub> =-10V, I <sub>d</sub> =-8A		17.1	21.0	mΩ
		V <sub>gs</sub> =-4.5V, I <sub>d</sub> =-4A		44.0		mΩ
Forward transconductance	G <sub>fs</sub>	V <sub>ds</sub> =-5V, I <sub>d</sub> =-8A		15		S
Diode forward voltage	V <sub>sd</sub>	I <sub>s</sub> =-1A, V <sub>gs</sub> =0V			-1	V
Max. body-diode continuous current	I <sub>s</sub>				-2.6	A
DYNAMIC PARAMETERS						
Input capacitance	C <sub>iss</sub>	V <sub>gs</sub> =0V, V <sub>ds</sub> =-15V, f=1MHz		1760	2200	pF
Output capacitance	C <sub>oss</sub>			360		pF
Reverse transfer capacitance	C <sub>rss</sub>			255		pF
Gate resistance	R <sub>g</sub>	V <sub>gs</sub> =0V, V <sub>ds</sub> =0V, f=1MHz		6.4	8.0	Ω
SWITCHING PARAMETERS						
Total gate charge	Q <sub>g</sub>	V <sub>gs</sub> =-10V, V <sub>ds</sub> =-15V I <sub>d</sub> =-8A		30	38	nC
Gate-source charge	Q <sub>gs</sub>			7		nC
Gate-drain charge	Q <sub>gd</sub>			8		nC
Turn-on delay time	t <sub>d(on)</sub>	V <sub>gs</sub> =-10V, V <sub>ds</sub> =-15V R <sub>l</sub> =1.8 Ω, R <sub>gen</sub> =3 Ω		12.5		ns
Turn-on rise time	t <sub>r</sub>			10.5		ns
Turn-off delay time	t <sub>d(off)</sub>			40.0		ns
Turn-off fall time	t <sub>f</sub>			23.0		ns
Body diode reverse recovery time	t <sub>rr</sub>	I <sub>f</sub> =-8A, dI/dt=100A/μs		24	30	ns
Body diode reverse recovery charge	Q <sub>rr</sub>	I <sub>f</sub> =-8A, dI/dt=100A/μs		16		nC

### NOTE :

1. The value of R<sub>θja</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board of 2oz. Copper, in still air environment with Ta=25°C. The value in any given applications depends on the user's specific board design, The current rating is based on the t ≤ 10s thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The R<sub>θja</sub> is the sum of the thermal impedance from junction to lead R<sub>θjl</sub> and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80μs pulses, duty cycle 0.5%max.
5. These tests are performed with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with Ta=25°C. The SOA curve provides a single pulse rating.

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## Typical electrical and thermal characteristics

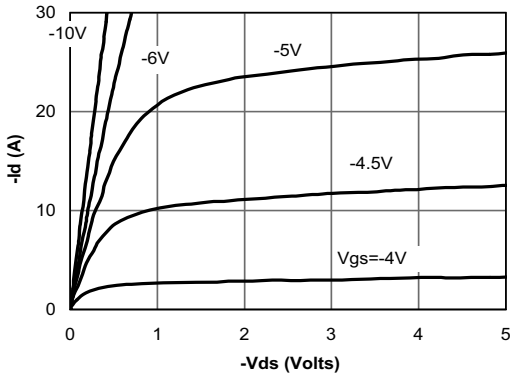


Fig 1: On-Region Characteristics

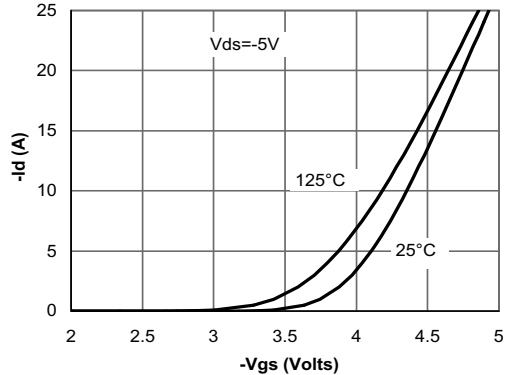


Figure 2: Transfer Characteristics

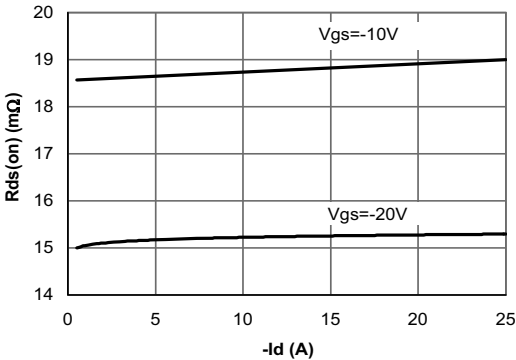


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

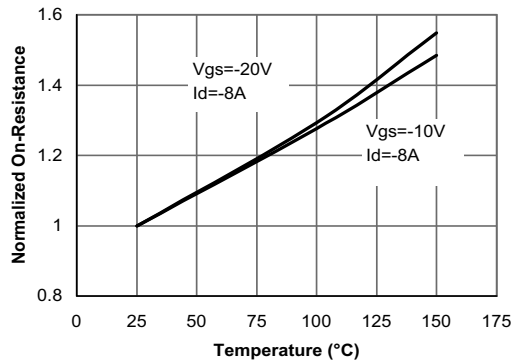


Figure 4: On-Resistance vs. Junction Temperature

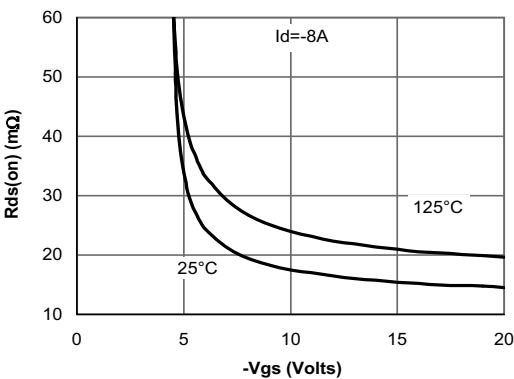


Figure 5: On-Resistance vs. Gate-Source Voltage

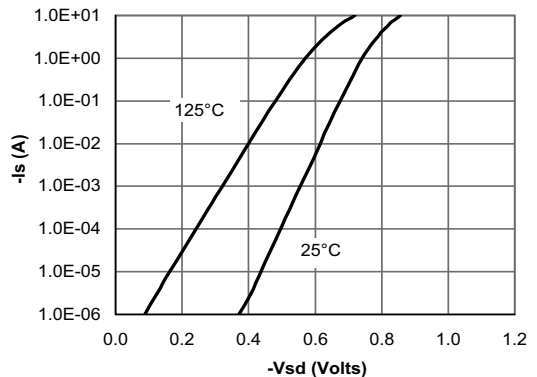


Figure 6: Body-Diode Characteristics

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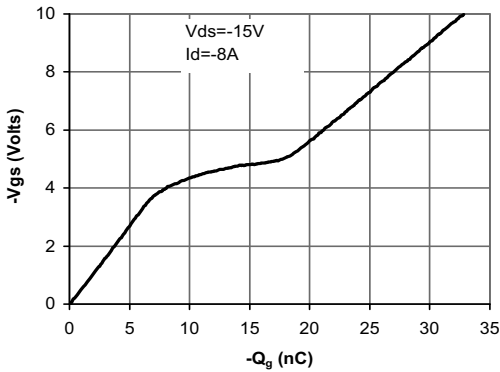


Figure 7: Gate-Charge Characteristics

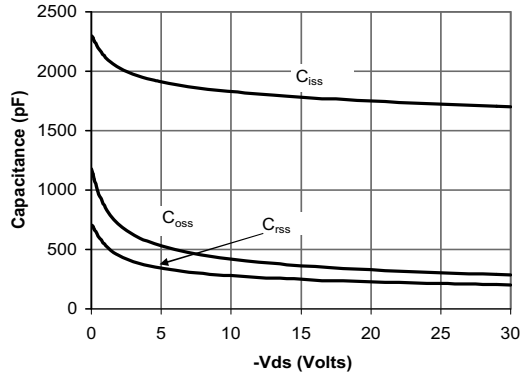


Figure 8: Capacitance Characteristics

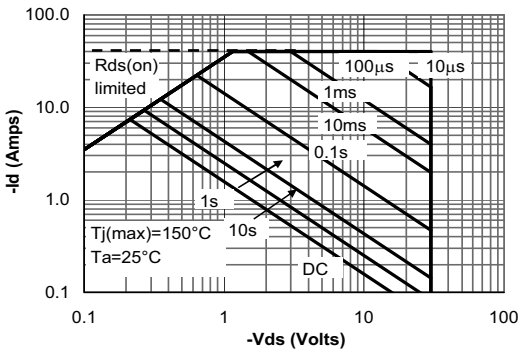


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

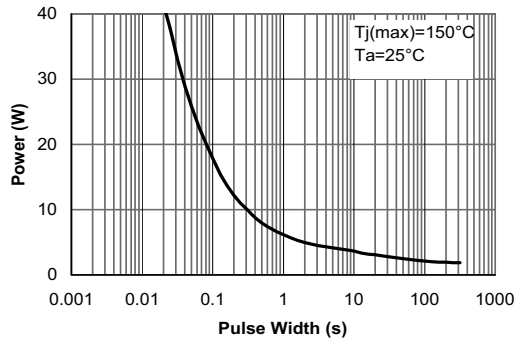


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

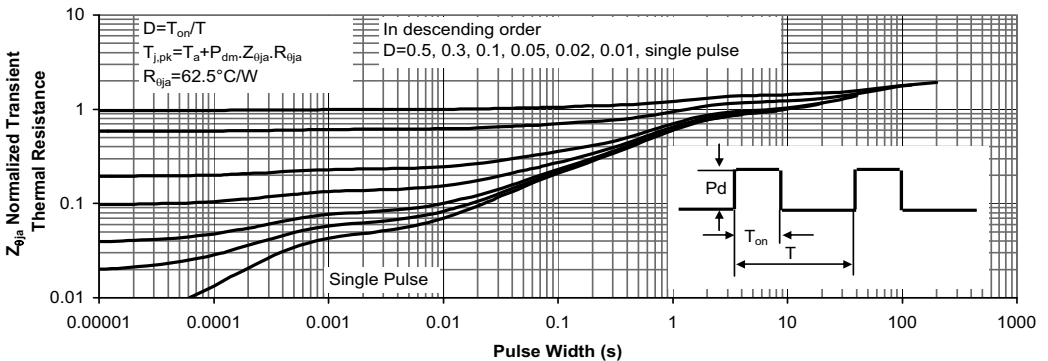


Figure 11: Normalized Maximum Transient Thermal Impedance